

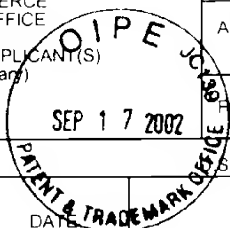
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APPLICANT

SEPPO KERONEN, ET AL.

FILING DATE October 8, 1999

GROUP 2876



## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>SEA</i>	5,434,395	7/18/95	Storck, et al.	235	380	
<i>SEA</i>	5,594,493	1/14/97	Nemirofsky	348	13	
<i>SEA</i>	5,412,416	5/2/95	Nemirofsky	348	10	
<i>SEA</i>	6,223,348	4/24/01	Hayes, et al.	725	152	
<i>SEA</i>	5,583,539	12/10/96	Hiketa, et al.	348	10	
<i>SEA</i>	5,479,205	12/26/95	Silverbrook	348	239	
<i>SEA</i>	5,353,016	10/4/94	Kurita, et al.	340	825	
<i>SEA</i>	2001-0017616	2/28/01	Kobayashi	345	173	

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
<i>SEA</i>	9520294	1/14/97	PCT/WO			
<i>SEA</i>	3,637,684	5/7/87	Germany			
<i>SEA</i>	1,039,772	9/27/00	Europe			
<i>SEA</i>	<del>606,287</del>	<del>7/24/94</del>	<del>Europe</del>			
<i>SEA</i>	2,696,888	4/15/94	France			
<i>SEA</i>	123,986	7/17/84	Japan			

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)


EXAMINER

*James J. Sweeney*

DATE CONSIDERED

*11/24/2002*

\*EXAMINER Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.